SN65LVDM31

SLLS417C-MARCH 2000-REVISED MAY 2001

HIGH-SPEED DIFFERENTIAL LINE DRIVER

FEATURES

• Designed for Signaling Rates

NOTE: The signaling rate is the number of voltage transitions that can be made per second.

Up to 150 Mbps

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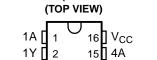
- Low-Voltage Differential Signaling With Typical Output Voltage of 700 mV and a 100- Ω Load
- Propagation Delay Time of 2.3 ns, Typical
- Single 3.3-V Supply Operation
- One Driver's Power Dissipation at 75 MHz, 50 mW, Typical
- High-Impedance Outputs When Disabled or With V_{CC} < 1.5 V
- Bus-Pin ESD Protection Exceeds 12 kV
- Low-Voltage CMOS (LVCMOS) Logic Input Levels Are 5-V Tolerant

DESCRIPTION

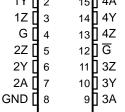
The SN65LVDM31 incorporates four differential line drivers that implement the electrical characteristics of low-voltage differential signaling. This product offers a low-power alternative to 5-V PECL drivers with similar signal levels. Any of the four current-mode drivers will deliver a minimum differential output voltage magnitude of 540 mV into a 100- Ω load when enabled by either an active-low or active-high enable input.

The intended application of this device and signaling technique is for both point-to-point and multiplexed baseband data transmission over controlled impedance media of approximately 100 Ω . The transmission media may be printed-circuit board traces, backplanes, or cables. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment.

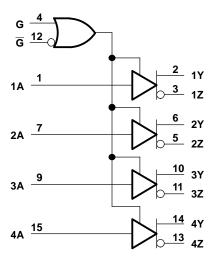
The SN65LVDM31 is characterized for operation from -40°C to 85°C.



SN65LVDM31D (Marked as LVDM31)



FUNCTIONAL BLOCK DIAGRAM



FUNCTION TABLE

INPUT	ENABLES		OUTI	PUTS	
Α	G	G	Y	Z	
Н	Н	Х	Н	L	
L	Н	Х	L	Н	
Н	Х	L	Н	L	
L	Х	L	L	Н	
Х	L	Н	Z	Z	
Open	Н	Х	L	Н	
Open	Х	L	L	Н	



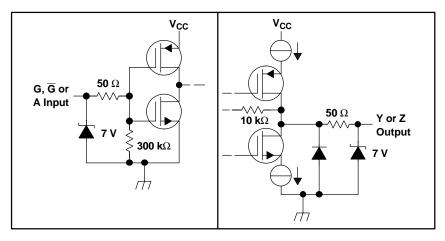
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		UNIT
Supply voltage range V _{CC} ⁽²⁾		–0.5 V to 4 V
	Inputs	–0.5 V to 6 V
Input voltage range	Y or Z	–0.5 V to 4 V
Electrostatic discharge ⁽³⁾ : Y, Z, and GND		Class 3, A:12 kV, B:600 V
Continuous power dissipation		See Dissipation Rating Table
Storage temperature range		–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- (2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.
- (3) Tested in accordance with MIL-STD-883C Method 3015.7.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	OPERATING FACTOR ⁽¹⁾	T _A = 85°C
	POWER RATING	ABOVE $T_A = 25^{\circ}C$	POWER RATING
D	950 mW	7.6 mW/°C	494 mW

(1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	3	3.3	3.6	V
V_{IH}	High-level input voltage	2.0			V
V_{IL}	Low-level input voltage			0.8	V
T _A	Operating free-air temperature	40		85	°C

ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP ⁽¹⁾	MAX	UNIT
	Differential output voltage magnitude	R _L = 100 Ω,	See Figure 2	540	700	860	mV
V _{OD}		R _L = 50 Ω,	See Figure 2	270	350	430	
$\Delta V_{OD} $	Change in differential output voltage magnitude between logic states	See Figure 2		-25	0	25	mV
V _{OC(SS)}	Steady-state common-mode output voltage	See Figure 3		1.14	1.2	1.3	V
$\Delta V_{OC(SS)}$	Change in steady-state common-mode output voltage between logic states			-30	0	30	mV
V _{OC(PP)}	Peak-to-peak common-mode output voltage				70	100	
· · ·		Enabled, No load			6	10	
I _{CC}	Supply current	Enabled, $R_L = 100 \Omega$	$V_{IN} = 0 \text{ or } V_{CC}$		35	40	mA
		Disabled			0.5	0.7	
I _{IH}	High-level input current	V _{IH} = 3 V		-10	3	10	μA
IIL	Low-level input current	$V_{IL} = 0 V$		-10	0	10	μA
		V_{OY} or $V_{OZ} = 0 V$			7	10	
I _{OS}	Short-circuit output current	$V_{OD} = 0 V$			7	10	mA
I _{OZ}	High-impedance state output current	$V_{O} = 0 V \text{ or } V_{CC}$				±1	μA
I _{O(OFF)}	Power-off output current	V _{CC} = 1.5 V,	V _O = 3.6 V			±1	μA

(1) All typical values are at 25°C and with a 3.3-V supply.

SWITCHING CHARACTERISTICS

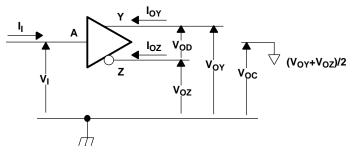
over recommended operating conditions (unless otherwise noted)

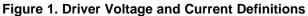
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high-level output		1.8	2.3	2.9	ns
t _{PHL}	Propagation delay time, high-to-low-level output		1.8	2.3	2.9	ns
t _r	Differential output signal rise time	Soo Figure 4	0.4	0.6	1.0	ns
t _f	Differential output signal fall time	See Figure 4	0.4	0.6	1.0	ns
t _{sk(p)}	Pulse skew (t _{PHL} – t _{PLH})			50	350	ps
t _{sk(o)}	Channel-to-channel output skew ⁽¹⁾				200	ps
t _{sk(pp)}	Part-to-part skew ⁽²⁾				1	ns
t _{PZH}	Propagation delay time, high-impedance-to-high-level output			6	15	ns
t _{PZL}	Propagation delay time, high-impedance-to-low level output	See Figure 5		6	15	ns
t _{PHz}	Propagation delay time, high-level-to-high-impedance output			6	15	ns
t _{PLZ}	Propagation delay time, low-level-to-high-impedance output			6	15	ns

(1) $t_{sk(o)}$ is the maximum delay time difference between drivers on the same device.

(2) t_{sk(pp)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

PARAMETER MEASUREMENT INFORMATION





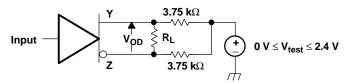
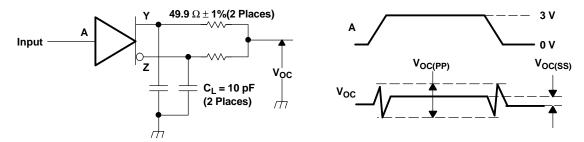
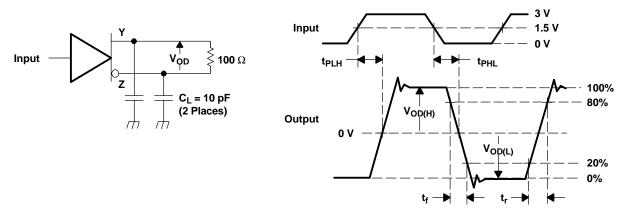


Figure 2. V_{OD} Test Circuit



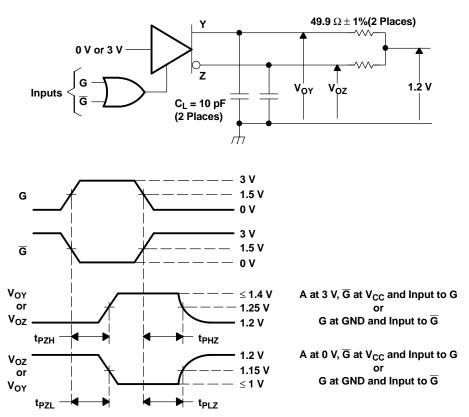
NOTE: All input pulses are supplied by a generator having the following characteristics: t_r or t_f ≤ 1 ns, pulse repetition rate (PRR) = 0.5 Mpps, pulse width = 500 ±10 ns. C_L includes instrumentation and fixture capacitance within 0,06 mm of the DUT. The measurement of V_{OC(PP)} is made on test equipment with a –3 dB bandwidth of at least 300 MHz.

Figure 3. Test Circuit and Definitions for the Driver Common-Mode Output Voltage



NOTE: All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 1$ ns, pulse repetition rate (PRR) = 50 Mpps, pulse width = 10 ±0.2 ns. C_L includes instrumentation and fixture capacitance within 0,06 mm of the DUT.

Figure 4. Test Circuit, Timing, and Voltage Definitions for the Differential Output Signal

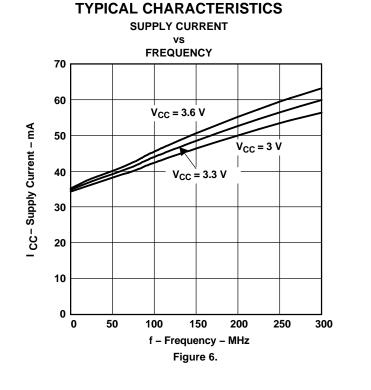


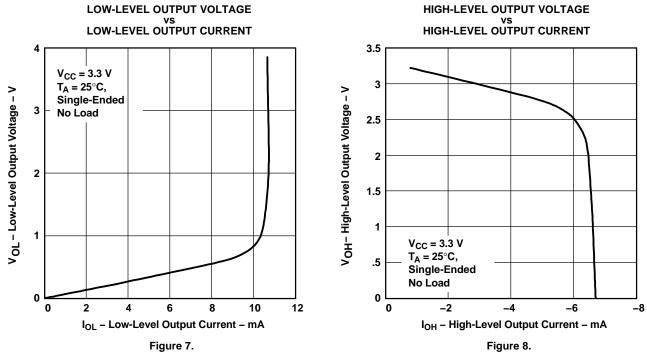
PARAMETER MEASUREMENT INFORMATION (continued)

NOTE: All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 1$ ns, pulse repetition rate (PRR) = 0.5 Mpps, pulse width = 500 ±10 ns. C_L includes instrumentation and fixture capacitance within 0,06 mm of the DUT.

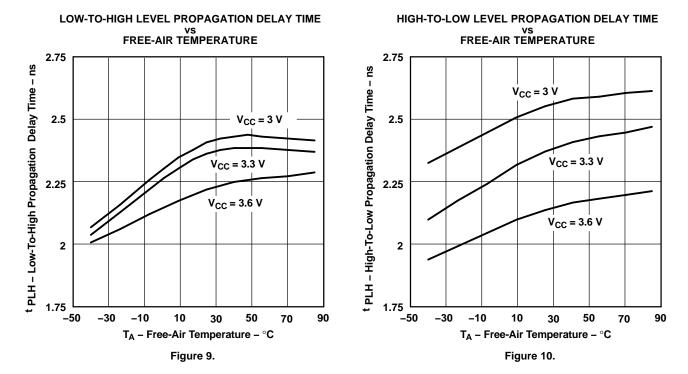
Figure 5. Enable and Disable Time Circuit and Definitions











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